

**Notice of References Cited**

Application/Control No.

10/535,350

Applicant(s)/Patent Under  
Reexamination  
BERBNER ET AL.

Examiner

FORREST M. PHILLIPS

Art Unit

2837

Page 1 of 4

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<b>Notice of References Cited</b>		Application/Control No. 10/535,350	Applicant(s)/Patent Under Reexamination BERBNER ET AL.	
		Examiner FORREST M. PHILLIPS	Art Unit 2837	Page 2 of 4

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	Examiner FORREST M. PHILLIPS		Art Unit 2837	Page 3 of 4

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FORREST M. PHILLIPS

Art Unit

2837

Page 4 of 4

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